Cover letter for Referencing Test Data for FCC ID:

2AH25V1SNFC

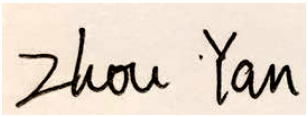
As the primary test lab for FCC ID: **2AH25V1SNFC** from Shanghai Sunmi Technology Co., Ltd., we, East China Institute of Telecommunications, according to 17 declaration of changes.pdf. Only Add NFC function without layout changes and add 2nd source battery, comparing with FCC ID: **2AH25V1S**.

Below is all the test results and referencing test data for your reference.

15B report		
	I17D00262-EMC01	New test
SAR report		
	I17D00262-SAR01	Full test
Bluetooth report		
Peak Output power-Conducted	CCISE170603503	the original product's test report
Frequency Band Edges-Conducted	CCISE170603503	r the original product's test report
Conducted Emission	CCISE170603503	the original product's test report
Radiated Emission	CCISE170603503	the original product's test report
Radiated Emission	I17D00262-SRD01	Worst case
Time of Occupancy(Dwell Time)	CCISE170603503	the original product's test report
20dB Bandwidth	CCISE170603503	the original product's test report original product's test report
Carrier Frequency Separation	CCISE170603503	the original product's test report
Number of Hopping Channels	CCISE170603503	the original product's test report
AC Powerline Conducted Emission	CCISE170603503	the original product's test report
AC Powerline Conducted Emission	I17D00262-SRD01	Worst case
BLE report		
Peak Output power-Conducted	CCISE170603502	the original product's test report
Peak Power Spectral Density	CCISE170603502	the original product's test report

6DB Bandwidth	CCISE170603502	the original product's test report
Frequency Band Edges-Conducted	CCISE170603502	the original product's test report
Conducted Emission	CCISE170603502	the original product's test report
Radiated Emission	CCISE170603502	the original product's test report
Radiated Emission	I17D00262-SRD02	Worst case
AC Powerline Conducted Emission	CCISE170603502	the original product's test report
AC Powerline Conducted Emission	I17D00262-SRD02	Worst case
Wi-Fi report		
Maximun Output Power	CCISE170603504	the original product's test report
Peak Power Spectral Density	CCISE170603504	the original product's test report
Occupied 6DB Bandwidth	CCISE170603504	the original product's test report
Bandedges Compliance	CCISE170603504	the original product's test report
Transmitter Spurious Emission-Conducted	CCISE170603504	the original product's test report
Transmitter Spurious Emission-Radiated	CCISE170603504	the original product's test report
Transmitter Spurious Emission-Radiated	I17D00262-SRD03	Worst case
AC Powerline Conducted Emission	CCISE170603504	the original product's test report
AC Powerline Conducted Emission	I17D00262-SRD03	Worst case
NFC report		
20dB Bandwidth	I17D00262-EMC04	New test
Frequency Stability	I17D00262-EMC04	New test
Radiates Emission	I17D00262-EMC04	New test
Conducted Emission	I17D00262-EMC04	New test
2G/3G		
Output Power	CCISE170603501	the original product's test report
Peak-to-Average Power Ratio	CCISE170603501	the original product's test report
Occupied Bandwidth	CCISE170603501	the original product's test report

-26DB Emission Bandwidth	CCISE170603501	the original product's test report
Band Edge At Antenna Terminals	CCISE170603501	the original product's test report
Frequency Stability	CCISE170603501	the original product's test report
Conducted Spurious Emission	CCISE170603501	the original product's test report
Radiated Emission	CCISE170603501	the original product's test report
Radiated Emission	I17D00262-SRD04	Worst case



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